

TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOSIII)

TPCS8302

Lithium Ion Battery Applications

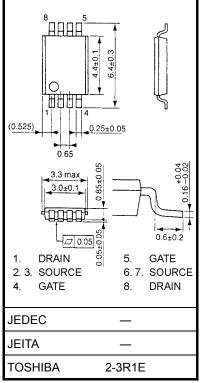
Notebook PC Applications

Portable Equipment Applications

- Small footprint due to small and thin package
- Low drain-source ON resistance: R_{DS} (ON) = 22 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 12 \text{ S} \text{ (typ.)}$
- Low leakage current: $IDSS = -10 \mu A (max) (VDS = -20 V)$
- Enhancement mode: $V_{th} = -0.5 \sim -1.2 \text{ V} (V_{DS} = -10 \text{ V}, \text{ Ip} = -200 \text{ }\mu\text{A})$

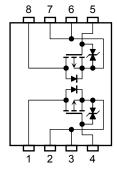
Char	acteristics	Symbol	Rating	Unit	
Drain-source vol	tage	V _{DSS}	-20	V	
Drain-gate voltag	ge (R _{GS} = 20 kΩ)	V _{DGR}	-20	V	
Gate-source volt	age	V _{GSS}	±12	V	
Drain current	DC (Note 1)	I _D	-5	А	
Drain current	Pulse (Note 1)	I _{DP}	-20 ±12	A	
Drain power	Single-device operation (Note 3a)	P _{D (1)}	1.1	W	
dissipation (t = 10 s) (Note 2a)	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.75		
Drain power dissipation (t = 10 s) (Note 2b)	Single-device operation (Note 3a)	P _{D (1)}	0.6	W	
	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.35		
Single pulse ava	e pulse avalanche energy (Note 4) E _{AS} 32.5		mJ		
Avalanche curre	nt	I _{AR}	-5	А	
Repetitive avalar Single-device va	nche energy lue at dual operation (Note 2a, 3b, 5)	E _{AR}	0.075	mJ	
Channel tempera	ature	T _{ch}	150	°C	
Storage tempera	ture range	T _{stg}	-55~150	°C	

Absolute Maximum Ratings (Ta = 25°C)



Weight: 0.035 g (typ.)

Circuit Configuration



Note: (Note 1), (Note 2), (Note 3), (Note 4) and (Note 5): See next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

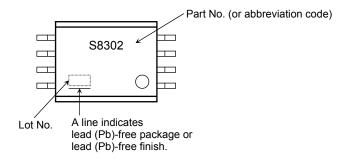
This transistor is an electrostatic-sensitive device. Please handle with caution.

Unit: mm

Thermal Characteristics

Characteristics	Symbol	Max	Unit		
	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	114	°C/W	
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	167		
Thermal resistance. channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	208		
(t = 10 s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)} 357		°C/W	

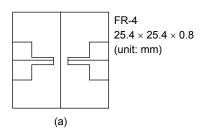
Marking (Note 6)



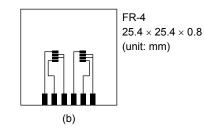
Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:

a) Device mounted on a glass-epoxy board (a)

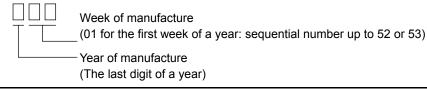


b) Device mounted on a glass-epoxy board (b)



Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is only applied to one device.)
- b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.)
- Note 4: $V_{DD} = -16 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}, \text{ L} = 1.0 \text{ mH}, \text{ I}_{AR} = -5 \text{ A}, \text{ R}_{G} = 25 \Omega$
- Note 5: Repetitive rating: pulse width limited by maximum channel temperature
- Note 6: \circ on lower right of the marking indicates Pin 1.
 - Weekly code: (Three digits)



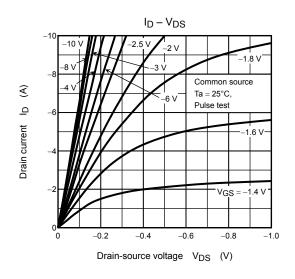
Electrical Characteristics (Ta = 25°C)

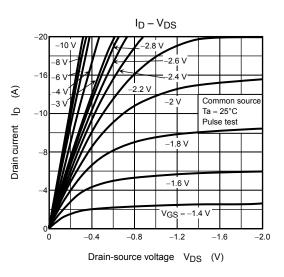
Ch	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	$V_{GS}=\pm 10~V,~V_{DS}=0~V$	_		±10	μA
Drain cut-OFF cu			_		-10	μA	
Drain-source bre	akdown voltage	V (BR) DSS	$I_D = -10$ mA, $V_{GS} = 0$ V	-20			v
Drain-source bre	andown voltage	V (BR) DSX	$I_D = -10$ mA, $V_{GS} = 12$ V	-8			v
Gate threshold ve	oltage	V _{th}	$V_{DS}=-10~V,~I_D=-200~\mu A$	-0.5		-1.2	V
			V_{GS} = –2.0 V, I_D = –2.5 A		42	95	
Drain-source ON resistance		R _{DS (ON)}	$V_{GS}=-2.5 \ \text{V}, \ \text{I}_{D}=-2.5 \ \text{A}$	_	32	60	mΩ
			$V_{GS}=-4.5 \text{ V}, \text{ I}_{D}=-2.5 \text{ A}$	_	22	35	
Forward transfer	Forward transfer admittance		$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -2.5 \text{ A}$	5.5	12	_	S
Input capacitance		C _{iss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz		1590	_	pF
Reverse transfer capacitance		C _{rss}			380	_	
Output capacitance		C _{oss}			430	_	
Input capacitance Reverse transfer capa Output capacitance Reverse transfer capa	Rise time	tr	$V_{GS} \xrightarrow{0}_{-5} V \xrightarrow{I_D = -2.5 \text{ A}}_{O} V_{OUT}$	_	9	_	- ns
	Turn-ON time	t _{on}		_	16		
	Fall time	t _f		—	45		
	Turn-OFF time	t _{off}	$V_{DD} \simeq 10 \text{ V}$ Duty $\leq 1\%, t_W = 10 \ \mu s$	_	113	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq 16$ V, $V_{GS} = -5$ V, $I_D = -5$ A	_	28.5		
Gate-source charge 1		Q _{gs}		_	19	_	nC
Gate-drain ("miller") charge		Q _{gd}		_	9.4	_	

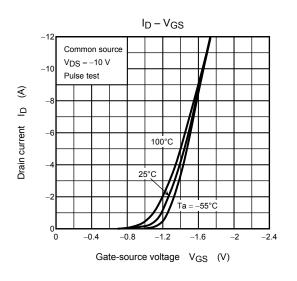
Source-Drain Ratings and Characteristics (Ta = 25°C)

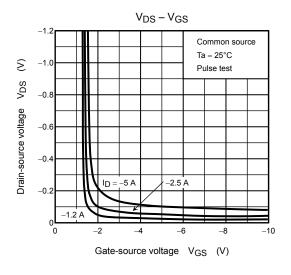
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	—	_	_	-20	А
Forward voltage (diode)		V _{DSF}	$I_{DR} = -5 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$	_		1.2	V

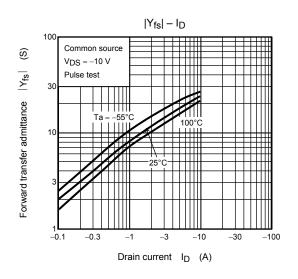
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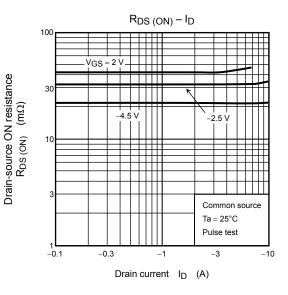




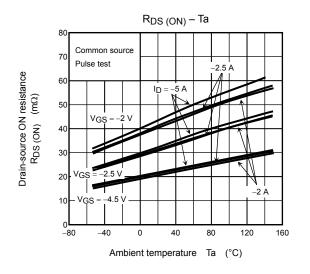


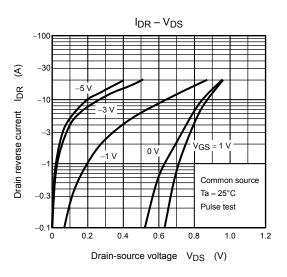


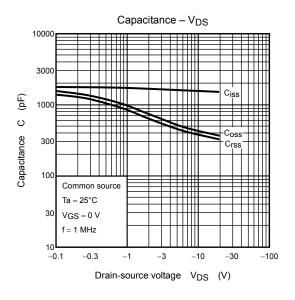


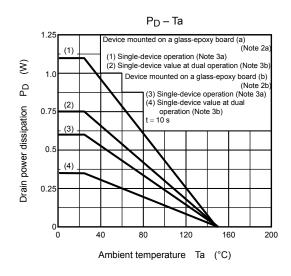


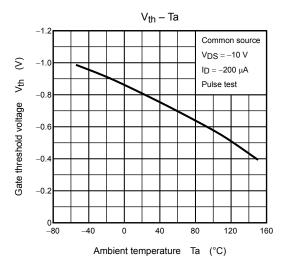
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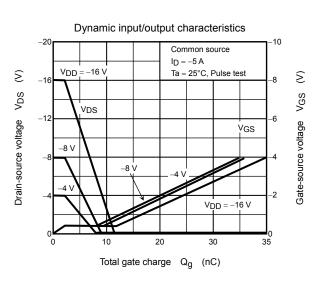








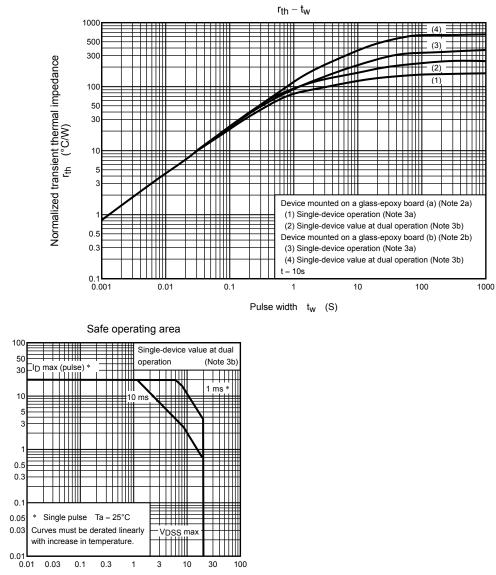




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Drain current



Drain-source voltage V_{DS} (V)

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